

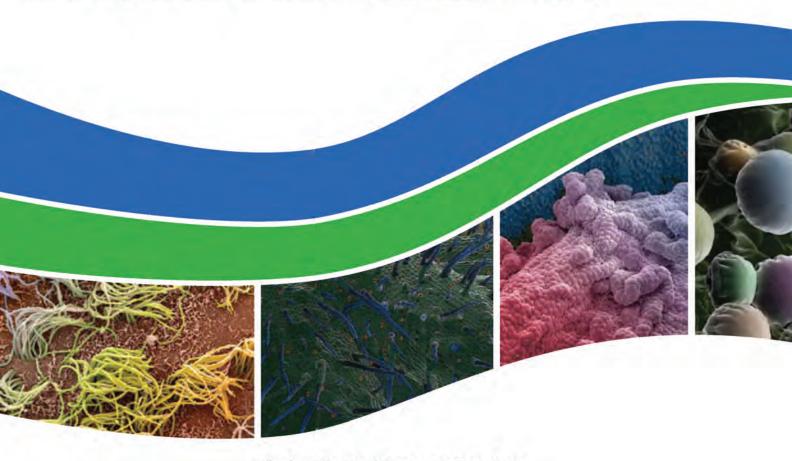
- Data collection at the highest speed and at the best resolution you can get – first class results no matter the circumstance
- Excellent light element performance with Mn K α ≤ 123 eV (F K α ≤ 54 eV, C K α ≤ 46 eV) even at 100,000 cps
- Best acquisition conditions for sensitive and rough samples through unique multi-detector systems and optimum geometry using VZ-Adapters
- Genuine standardless P/B-ZAF quantification for rough samples and VZ applications, Cliff-Lorimer quantification for TEM

www.bruker.com/microanalysis

EDS

You've made the Decision to Join.

Now Stay Engaged by Visiting the MSA Web Site | http://www.microscopy.org



Benefit from your Membership 24 Hours a Day. Thanks for your Interest in the Microscopy Society of America! Check out the Latest News on our Home Page

Register for conferences online

View and purchase educational materials

Connect with peers in your specialty, or other members in your city

Share information with MSA leaders, or become a volunteer

Get up to date on local, national and international microscopy events

Renew and update your profile online

Utilize our online networking tools

View MSA newsletters and articles 24/7

Get information on annual scholarships

Visit our expanding members-only portal for additional resources

Find a new vendor partner, and see the latest updates in instrumentation



12100 Sunset Hills Rd. | Suite 130 | Reston, VA 20190 P: 703.234.4115 | F: 703.435.4390 http://www.microscopy.org

Preparation Equipment and — Microscopy Supplies —

The single source for All your microscopy supplies and specimen preparation equipment.

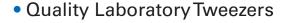


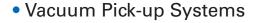
- Vacuum Coating Systems
- Calibration Standards



- PELCO[®] easiGlow[™] Glow Discharge Unit
- SEM Sample Holders and Mounts
- Silicon Nitride TEM Membranes
- PELCO BioWave Pro[®] Tissue Processor
- TEM Support Films









- Conductive Adhesives
- FIB Supplies













Complete line of compact Cressington EM Sample Coaters.



sales@tedpella.com

800-237-3526

www.tedpella.com



FIVE GENERATIONS OF PERFORMANCE...REFINED

The new Desk V HP sputtering tool.

With an enhanced sputter head, larger mechanical pump, a more powerful PLC and a larger power supply, the all new Desk V HP is generations ahead of the competition.

Features:

- Short deposition times
- Consistent deposition parameters
- Enhanced touchscreen controls
- Film thickness control
- Etch mode for sample cleaning
- Wide variety of coating materials
- Compact benchtop design
- 85 LPM Mechanical Pump

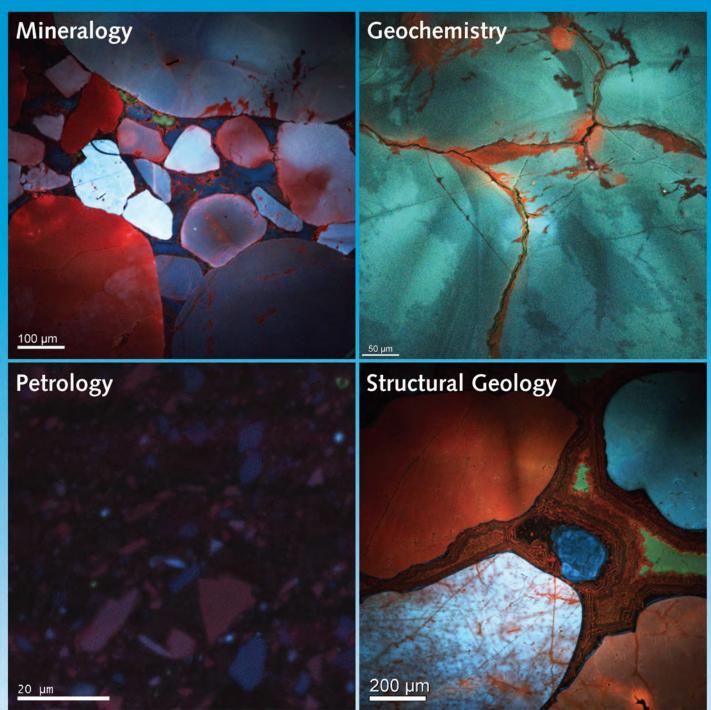




Call us today at 800-666-6004 or visit us online at www.dentonvacuum.com

INDEX TO ADVERTISERS	
Advanced Microscopy Techniques, AMT	A9
Bruker	A13
Denton Vacuum	A16
Diatome	A11, 846
Electron Microscopy Sciences, EMS	A3
Gatan	Cover 3
JEOL USA	A6, Cover 4
Leica Microsystems, Inc	Cover 2
Scientific Instruments & Applications (SI&A)	A5
SPI Supplies/Structure Probe, Inc.	A12
Ted Pella, Inc.	A15

Revealing Interfaces



Mineralogy: Quartz arenite polished section cathodoluminescence image prepared using the Gatan Ilion^{+™} and imaged with Gatan ChromaCL[™] imaging system. Image courtesy of Dr. J. Schieber, Indiana University. Geochemistry: Late-stage hydrothermal chemical alteration (red) associated with cracks in quartz (blue-green) in granite acquired with Gatan ChromaCL[™]. Image courtesy of Dr. J. Schieber, Indiana University. Structural Geology: Quartz arenite polished section cathodoluminescence image prepared using the Gatan Ilion^{+™} and imaged with Gatan ChromaCL[™] imaging system. Image courtesy of Dr. J. Schieber, Indiana University. Petrology: Oil shale polished section cathodoluminescence image prepared using the Gatan Ilion^{+™} and imaged with Gatan ChromaCL[™] imaging system.



ANALYTICAL TEM
DIGITAL IMAGING
SPECIMEN PREPARATION
TEM SPECIMEN HOLDERS
SEM PRODUCTS
SOFTWARE
X-RAY MICROSCOPY

Surface Preparation for SEM Cross Section and Planar Viewing



Touch Scope

Get in touch with this new class of SEM



- SEM apps at your fingertips
- Compact, portable, affordable
- Integrated EDS analysis
- Low vacuum and high vacuum imaging
- Wireless tablet operation
- Award-winning service and support



JEOL

Another
Extreme Imaging

Global Solutions Provider for Advanced Technology www.jeolusa.com • salesinfo@jeol.com

Performance Multi-Touch



SEN

JSM-6010LA

See it at http://www.jeolusa.com/intouch